Application/Control No. Applicant(s)/Patent Under Reexamination 10/501,864 TAMURA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Robert D. Harlan 1713 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D Ε US-US-F US-G US-Н USı US-J US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY * JP 2000-309701 11-2000 **JPC** Ν Yamazaki, Yuei 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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